July 2014

FAN4149
Ground Fault Interrupter

Features

- Meets 2015 UL943 Self-Test Requirements *(in combination with FAN41501)*
- Precision Sense Amplifier and Bandgap Reference
- Low-V_{OS} Offset for Direct DC Coupling of Sense Coil
- Built-in Noise Filter
- High-Current SCR Gate Driver
- Adjustable Sensitivity
- 500 μA Quiescent Current
- Minimum External Components
- Ideal for 120 V or 220 V Systems
- Space-Saving, SOT23, 6-Pin Package

Applications

- GFCI Output Receptacle
- GFCI Circuit Breakers
- Portable GFCI Cords
- Residual-Current Devices (RCD)

Description

The FAN4149 is a low-power controller for detecting hazardous current paths to ground and ground-to-neutral faults. The FAN4149 application circuit opens the load contacts before a harmful shock occurs.

The FAN4149, in combination with the FAN41501 auto-monitoring digital controller, meets the 2015 UL943 self-test requirements for permanently connected GFCI products. The FAN4149 detects and protects against a hot-wire-to-ground fault and a neutral-to-line/load short. The FAN41501 periodically monitors the FAN4149 and critical GFI components to comply with the 2015 UL943 requirements. The minimum number of components and the small 6-pin package allow for a dense, flexible, application solution.

The FAN4149 contains a precision bandgap 14 V shunt regulator, precision low-V_{OS} sense amplifier, time-delay noise filter, window-detection comparators, and an SCR driver. The shunt regulator operates with a low quiescent current, which allows for a high value, low-wattage series supply resistor. The internal temperature compensated shunt regulator, sense amplifier, and bias circuitry provide for precision ground-fault detection. This enables the use of larger component variations so that binning or trimming external components is not required. The typical ±50 μV V_{OS} sense amplifier offset allows for direct DC coupling of the sense coil. This eliminates the large AC-coupling capacitor. The internal delay filter rejects high-frequency noise spikes common with inductive loads. This decreases false nuisance tripping. The SCR driver provides increased current and temperature compensation to allow for a wider selection of external SCRs.

The minimum number of external components and the 6-pin SOT23 package allow a low-cost, compact design and layout.

Ordering Information

Part Number	Operating Temperature Range	Package	Packing Method
FAN4149M6X	-35°C to +85°C	6-Lead, SOT23, JEDEC M0-178, 1.6 mm	Tape and Reel

Block Diagram

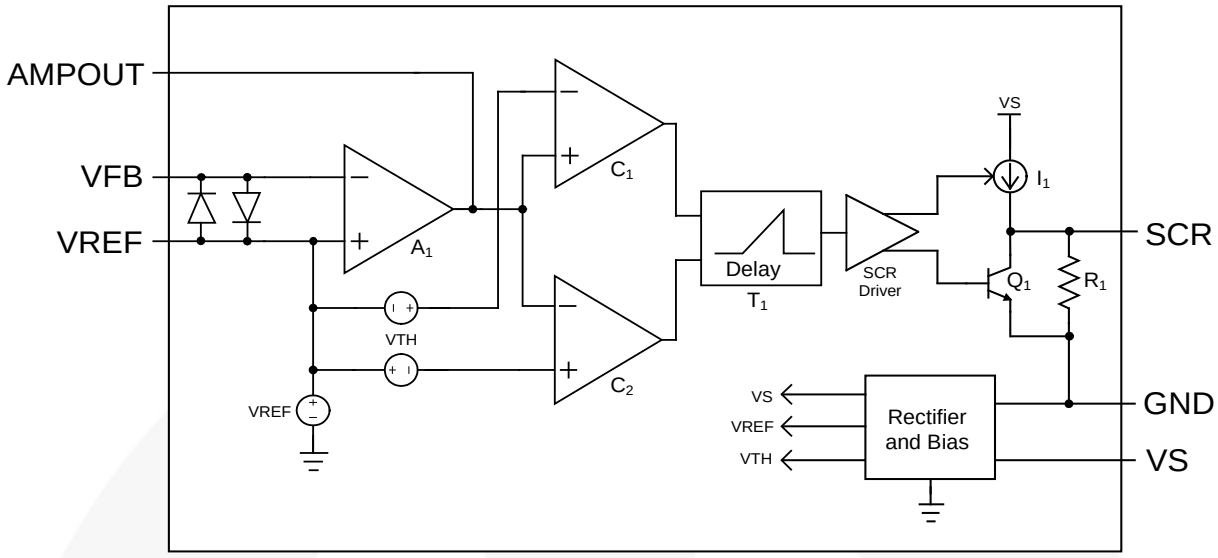


Figure 1. Block Diagram

Typical Application

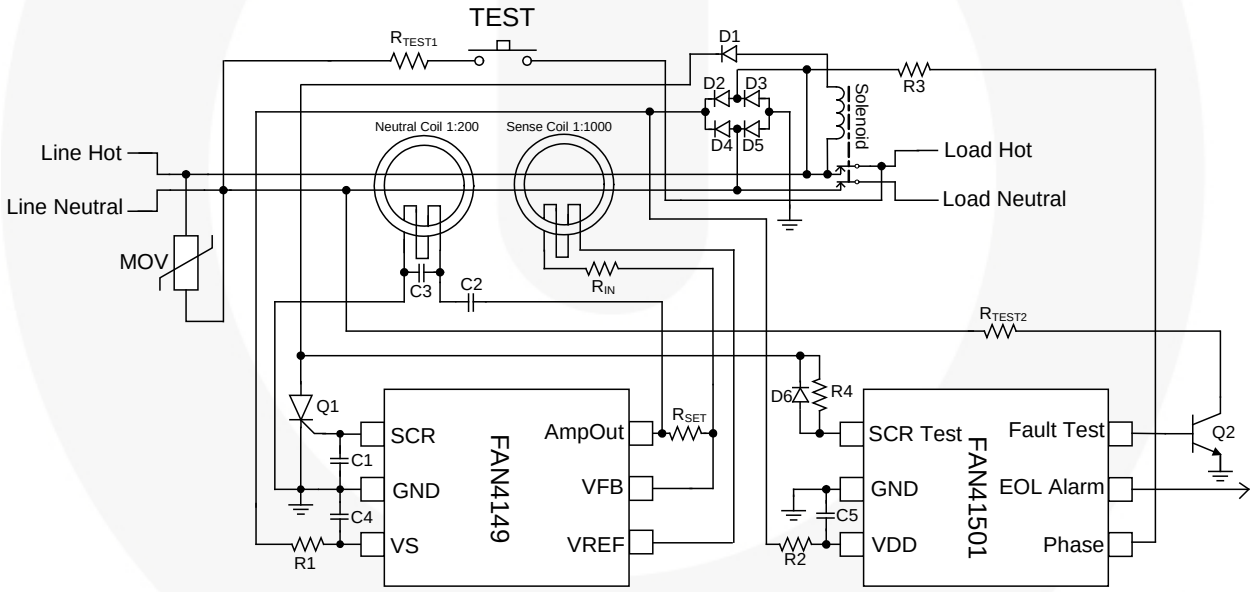


Figure 2. Typical Application(1,2)

Table 1. Typical Values

R1: 75 kΩ	R_{IN}: 470 Ω	R_{TEST1}: 15 kΩ	R_{TEST2}: 10 kΩ	R_{SET}: 750 kΩ (3)
R2: 75 kΩ	R3: 1 MΩ	R4: 909 kΩ	C1: 22 nF	C2: 10 nF
C3: 5.6 nF	C4: 220 nF	C5: 1 μF		

XMFR: Magnetic Metals 5029/F3006

Notes:
1. Contact Fairchild for self-test requirement details.
2. Portions of this schematic are subject to U.S. patents 8,085,516 and 8,760,824.
3. Value depends on sense-coil characteristics and application.

Pin Configuration

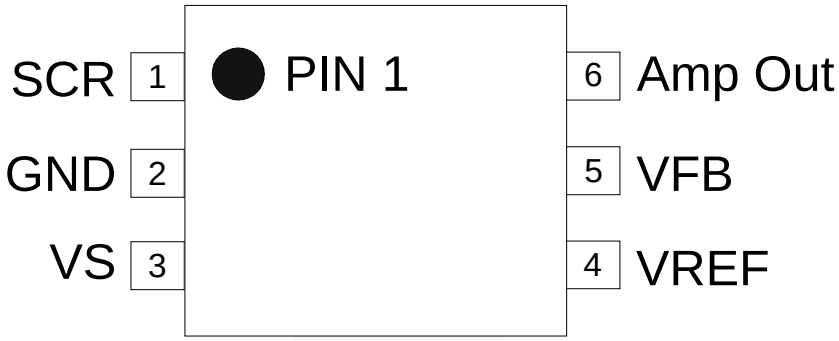


Figure 3. Pin Configuration

Pin Definitions

Pin #	Name	Description
1	SCR	Gate drive for external SCR
2	GND	Supply input for FAN4149 circuitry
3	VS	Supply input for FAN4149 circuitry
4	VREF	Non-inverting input for current sense amplifier
5	VFB	Inverting input for current sense amplifier
6	Amp Out	An external resistor connected to VFB sets the I_{FAULT} sensitivity threshold

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Condition	Min.	Max.	Unit
I_{CC}	Supply Current	Continuous Current, VS to GND		15	mA
V_{CC}	Supply Voltage	Continuous Voltage to GND, All Pins	-0.8	16.0	V
T_{STG}	Storage Temperature Range		-65	+150	°C
ESD	Electrostatic Discharge Capability	Human Body Model, ANSI/ESDA/JEDEC JS-001-2012		2.5	kV
		Charged Device Model, JESD22-C101		1.0	

DC Electrical Characteristics

Unless otherwise specified, T_A=25°C, I_{shunt}=1 mA, and referencing Figure 2.

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{REG}	Power Supply Shunt Regulator Voltage	VS to GND	13.7	14.0	14.3	V
I_Q	Quiescent Current	Line to GND=10 V	425	500	575	µA
V_{REF}	Reference Voltage	V_{REF} to GND	6.85	7.00	7.15	V
V_{TH}	Trip Threshold	Amp Out to VREF	4.35	4.50	4.65	V
V_{OS}	Amplifier Offset	Gain=1000	-175	±50	175	µV
	Amplifier Offset Drift[4]	Gain=1000	-100		100	µV
I_{OS}	Amplifier Input Offset[5]	Design Value	-50	0	50	nA
G	Amplifier DC Gain[5]	Design Value		100		dB
f_{GBW}	Amplifier Gain Bandwidth[5]	Design Value		3		MHz
V_{SW+}	Amplifier Positive Voltage Swing	Amp Out to VREF, I_{FAULT}=10 µA	5.5			V
V_{SW-}	Amplifier Negative Voltage Swing	VREF to Amp Out, I_{FAULT}=-10 µA	5.5			V
I_{SINK}	Amplifier Current Sink	Amp Out=V_{REF} + 3 V V_{FB}=V_{REF} + 100 mV	400			µA
I_{SRL}	Amplifier Current Source	Amp Out=V_{REF} – 3 V,V_{FB}=V_{REF} -100 mV	400			µA
t_d	Delay Filter	Delay from C_1 Trip to SCR L->H	0.65	1.00	1.35	ms
R_{OUT}	SCR Output Resistance	SCR to GND=250 mV, Amp Out=V_{REF}		0.5	1.0	kΩ
V_{OUT}	SCR Output Voltage	SCR to GND, Amp Out=V_{REF}		1	10	mV
	SCR Output Voltage	SCR to GND, AMP Out=V_{REF} +4 V	3.0			V
I_{OUT}	SCR Output Current	SCR to GND=1 V Amp Out=V_{REF} + 4 V, I_{SHUNT}=2 mA	650	725		µA

Notes:

4. Maximum V_{OS} offset temperature cycling drift from initial value (JEDEC JESD22-A104).
5. Guaranteed by design, not tested in production.

Functional Description

Refer to Figure 2.

The FAN4149 is a GFCI controller for AC ground-fault circuit interrupters. The low-V_{OS} offset for the sense amplifier allows for direct DC coupling of the sense coil when the FAN4149 is biased with a full-wave diode bridge. This allows for the FAN4149 to be used with the FAN41501 digital auto-monitoring controller to provide for a low-BOM-cost, complete, GFI solution with self testing for the critical GFCI components.

The internal shunt regulator rectifier circuit is supplied from the full-wave rectifier bridge and 75 kΩ series resistor. A typical 220 nF V_S bypass capacitor is used to filter the V_{AC} ripple voltage. The internal 14 V shunt regulator uses a precision temperature-compensated bandgap reference. The combination of precision reference circuitry and precision sense amplifier provides for an accurate ground-fault tolerance. This allows for selection of external components with wider and lower-cost parameter variations. Due to the low quiescent current, a high-value external series resistor (R_1) can be used to reduce the maximum power wattage required for this resistor. The 14 V shunt regulator generates the V_{REF} reference voltage for the sense amplifier's (A_1) non-inverting input (AC ground reference). It also supplies the bias for the delay timer (t_1), comparators (C_1 & C_2), and the SCR driver.

The secondary winding of the sense transformer is connected to pin 4 (VREF) and to a resistor, R_{IN}, which is directly DC connected to the inverting input of the sense amplifier at pin 5 (VFB). The feedback resistor (R_{SET}) converts the sense transformer's secondary current to a voltage at pin 6 (Amp Out). This voltage is compared to the internal window comparator (C_1 & C_2). When the Amp Out voltage exceeds the $\pm V_{TH}$ threshold voltage, the window comparator triggers the internal delay timer. The output of the window comparator must stay HIGH for the duration of the t_1 timer. If the window comparator's output goes LOW, the internal delay timer starts a reset cycle. If the window comparator's output is still HIGH at the end of the t_1 pulse, the SCR driver enables current source I_1 and disables Q1. Current source I_1 then enables the external SCR; which energizes the solenoid, opens the contact switches to the load, and removes the hazardous ground fault. The window comparator allows for detection of a positive or negative I_{FAULT} signal, independent from the phase of the line voltage.

Calculation of R_{SET} Resistor

The Amp Out signal must exceed the window comparator's V_{TH} threshold voltage for longer than the delay timer and calculated by:

$$V_{TH} = I_{FAULT} \times 1.22 \times R_{SET} \times \cos(2\pi \times (t/2P)) / N \quad (1)$$

$$R_{SET} = (V_{TH} \times N) / (1.22 \times I_{FAULT} \times \cos(\pi \times t/P)) \quad (2)$$

where:

V_{TH} = 4.5 V

I_{FAULT} = 5 mA_{RMS} (UL943)

T = 1 ms (timer delay)

P = Period of the AC Line (1/60 Hz)

P = Period of the AC Line (1/60 Hz)

N= Ratio of secondary-to-primary turns (1000:1)

R_{SET} = 750 kΩ (standard 1% value)

In practice, the transformer is non-ideal, so R_{SET} may need to be adjusted by up to 30% to obtain the desired I_{FAULT} trip threshold.

Calculation of V_{OS} Trip Threshold Error

Since the sense coil is directly connected to the feedback of the sense amplifier, the V_{OS} offset introduces an I_{FAULT} threshold error. This error can be calculated as follows:

$$\%Error = 100 \times (V_{OS} \times R_{SET}) / (R_{IN} + R_{LDC}) / V_{TH} \quad (3)$$

where:

V_{OS} = ±175 µV (worst case)
±50 µV (typical)

R_{SET} = 750 kΩ

R_{IN} = 470 Ω (typical value)

R_{LDC} = 75 Ω (sense coil secondary DC resistance)

V_{TH} = 4.5 V

%Error= ± 5.4% (worst case)
± 1.5% (typical)

The V_{OS} ±100 µV maximum drift specification is based on temperature cycling per JEDEC JESD22-A104, Condition B, 850 temperature cycles at -55°C to +125°C.

Grounded Neutral Detection

If the neutral load terminal side is incorrectly connected to the earth ground, the sense coil does not correctly detect the hazardous ground fault current from "load hot" to earth ground due to the partial I_{FAULT} current flowing from the grounded neutral fault (load neutral) to earth ground.

To detect a grounded neutral fault, a grounded neutral coil is required. When a low resistive path occurs from the line neutral and load neutral terminals, the sense and neutral coils are mutually coupled. The mutual coupling produces a positive feedback path around the sense amplifier, which causes the sense amplifier to oscillate. When the peak oscillation voltage exceeds the SCR trigger threshold, the internal delay timer is enabled. Since the amplifier's output signal is crossing the window comparator's trip threshold typically at 6 kHz, the delay timer alternates between detection of a fault/no-fault. The ratio of the fault/no-fault detection time interval determines if the SCR driver is enabled.

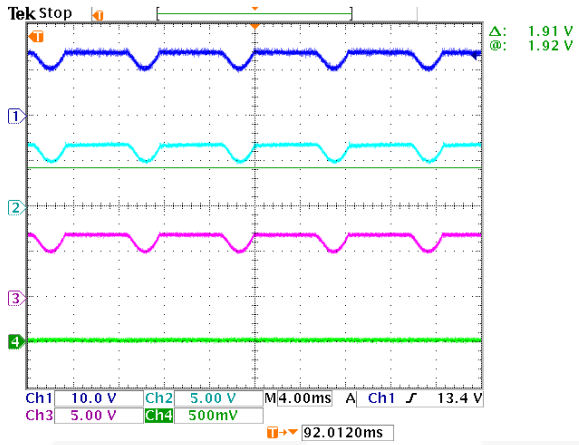
The sensitivity of the grounded neutral detection can be changed by the neutral coil turns and the value of C_2 and C_3.

GFCI Self Test Requirement

Starting in June of 2015, UL943 requires all permanently connected GFCI products to perform a self-test function. By adding Fairchild's FAN41501 product to the FAN4149 application (*see Figure 2),* a fully compliant 2015 UL943 self-test function can be achieved with two, small, independent, 6-pin, 1.6 mm-wide devices and a minimum number of external components. The 2015 UL code requires that, at power up, the GFCI self test the critical GFCI components -- FAN4149, SCR, sense coil, and solenoid -- within five seconds and thereafter within every three hours. The self-test cycle cannot open the load contacts. If a component failure is detected, the load power must be denied. *Refer to the FAN41501 datasheet for more details about the UL943 self-test features.*

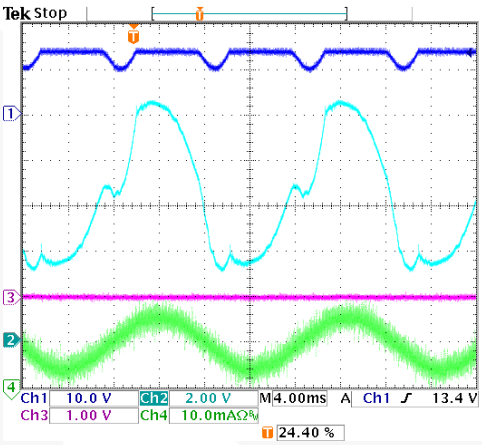
Typical Performance Characteristics

Unless otherwise specified, T_A=25°C and according to Figure 2 with SCR disconnected.



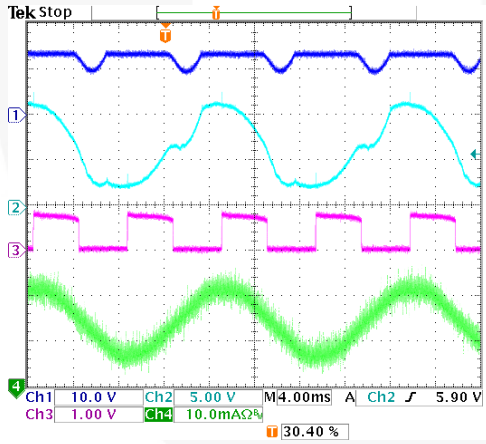
Ch1: VS (Pin 3), 10 V/Div
Ch2: AmpOut (Pin 6), 5 V/Div
Ch3: VREF (Pin 4), 5 V/Div
Ch4: SCR (Pin 1), 500 mV/Div

Figure 4. Typical Waveforms, No Ground Fault



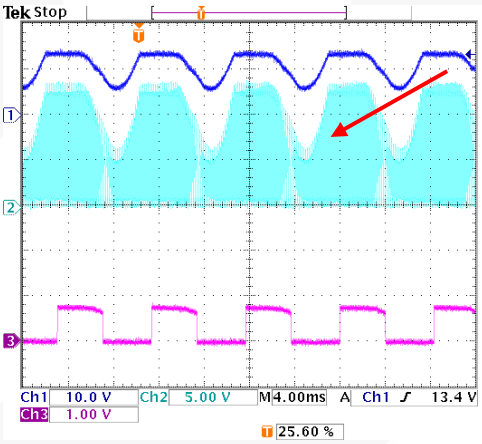
Ch1: VS (Pin 3), 10 V/Div
Ch2: AmpOut (Pin 6), 2 V/Div
Ch3: SCR (Pin 1), 1 V/Div
Ch4: I_{FAULT}, 10 mA/Div

Figure 5. Typical Waveforms, 4 mA Ground Fault



Ch1: VS (Pin 3), 10 V/Div
Ch2: AmpOut (Pin 6), 5 V/Div
Ch3: SCR (Pin 1), 1 V/Div
Ch4: I_{FAULT}, 10 mA/Div

Figure 6. Typical Waveforms, 5 mA Ground Fault



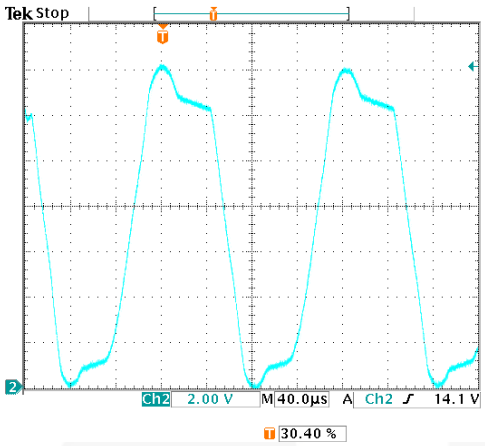
Ch1: VS (Pin 3), 10 V/Div
Ch2: AmpOut (Pin 6), 5 V/Div
Ch3: SCR (Pin 1), 1 V/Div

Figure 7. Typical Waveforms for Grounded Neutral Detection

Continued on the following page…

Typical Performance Characteristics (Continued)

Unless otherwise specified, T_A=25°C and according to Figure 1 with SCR disconnected.



Ch2: AmpOut (Pin 6), 2 V/Div

Figure 8. Typical Waveform for Grounded Neutral Detection

Typical Temperature Characteristics

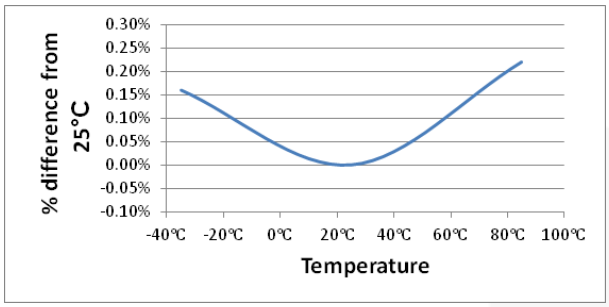


Figure 9. Shunt Regulator Voltage vs. Temperature

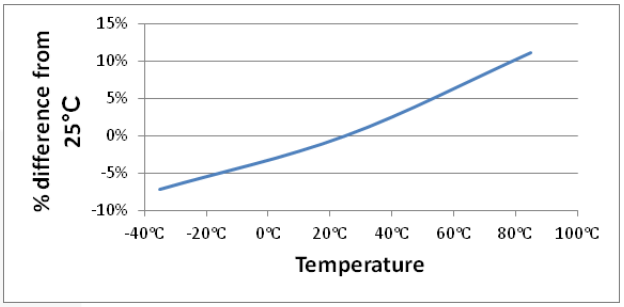


Figure 10. Quiescent Current vs. Temperature

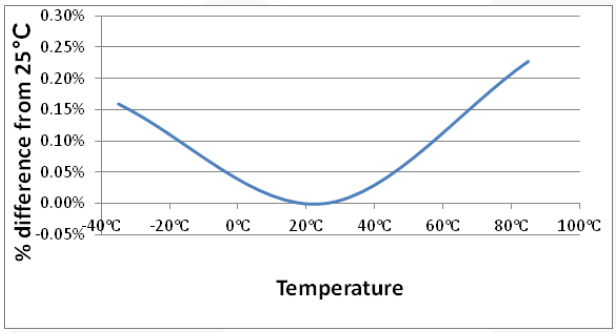


Figure 11. Reference Voltage vs. Temperature

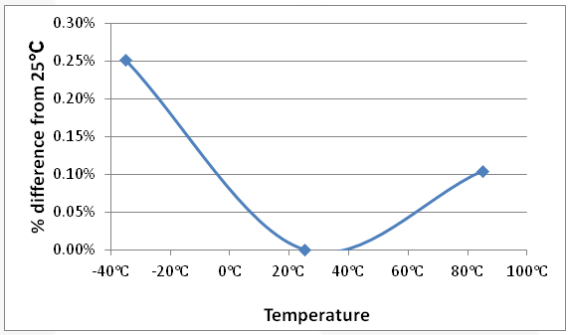


Figure 12. VH Threshold Voltage vs. Temperature

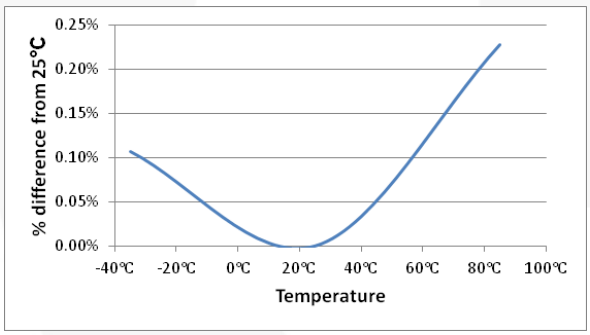


Figure 13. VL Threshold Voltage vs. Temperature

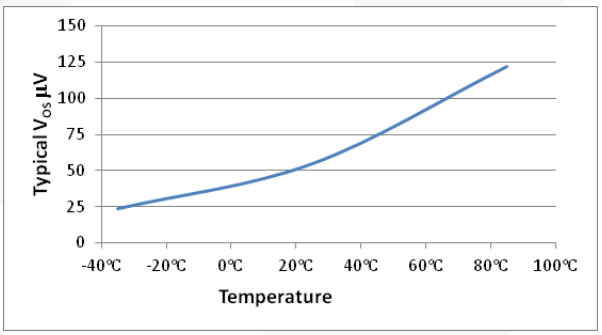


Figure 14. Typical V_{OS} vs. Temperature

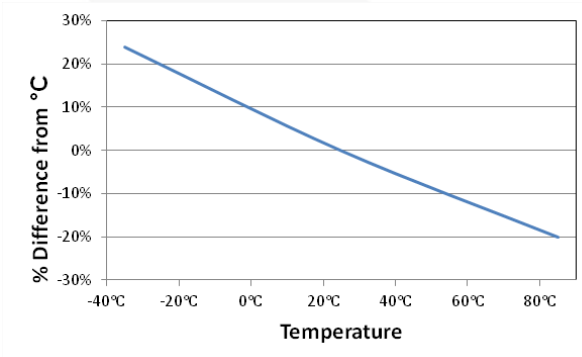
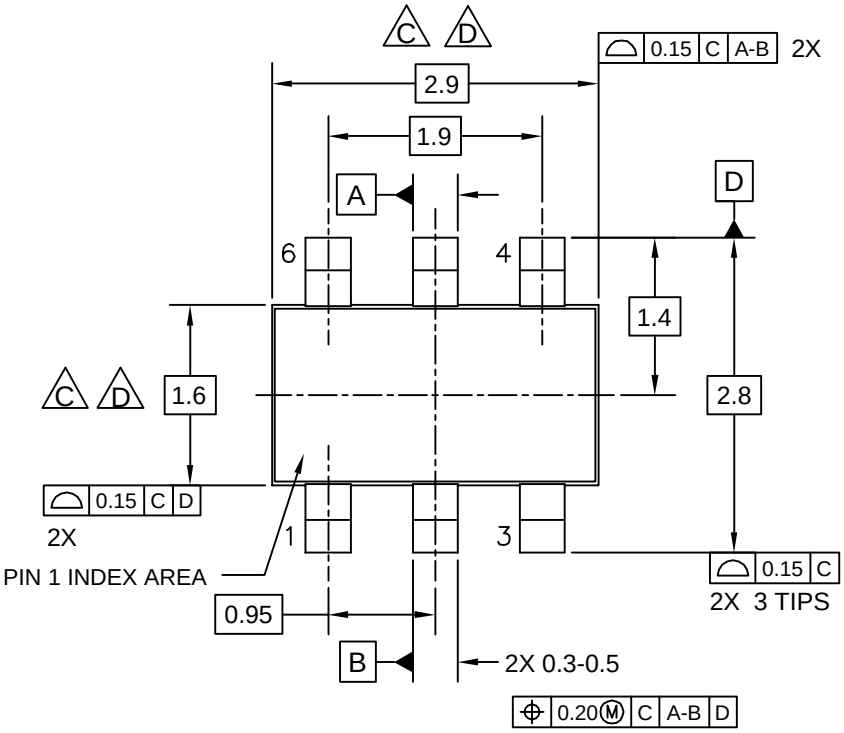
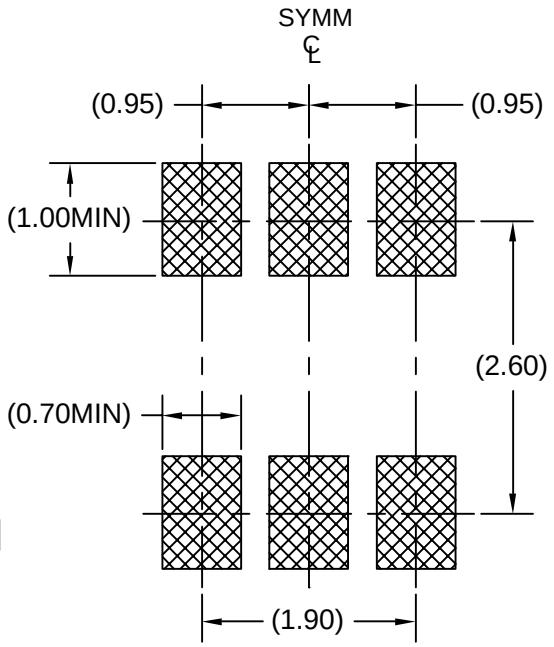


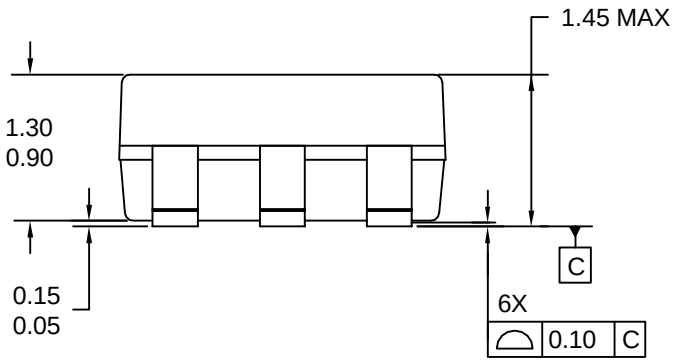
Figure 15. I_{OUT} SCR Out vs. Temperature

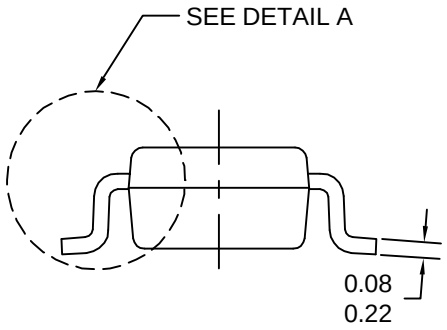
REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
A	RELEASE TO DOCUMENT CONTROL	ECN-MKT-MA06E	11/4/2006	H.ALLEN
2	DWG UPDATED TO CONFORM TO MO178		5 JULY 07	L.HUEBENER

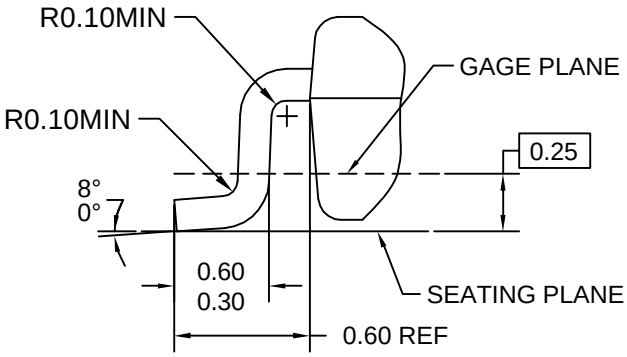




LAND PATTERN RECOMMENDATION







DETAIL A
SCALE: 2:1

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B. ALL DIMENSIONS ARE IN MILLIMETERS.
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D. DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSIONS.
E. DIMENSIONS AND TOLERANCING AS PER ASME Y14.5M-1994
F. DRAWING FILE NAME: MA06EREV2

APPROVALS	DATE
DRAWN: L.HUEBENER	5 JULY 07
CHECKED: H.ALLEN	17 JULY 07
APPROVED:	

FAIRCHILD SEMICONDUCTOR™

6LD,SOT23,JEDEC MO-178 VARIATION AB, 1.6MM WIDE

PROJECTION	SCALE	SIZE	DRAWING NUMBER	REV
INCH [MM]	1:1	N/A	MKT-MA06E	2

FORMERLY: N/A SHEET: 1 OF 1

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ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

AMEYA360
Components Supply Platform

Authorized Distribution Brand :

Website :

Welcome to visit www.ameya360.com

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